## Notice of References Cited Application/Control No. 10/667,732 Examiner Khanh H. Le Applicant(s)/Patent Under Reexamination KANG ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,141,010	10-2000	Hoyle, Martin David	715/854
*	В	US-6,865,719	03-2005	Nicholas, III, James J.	715/856
*	C	US-6,973,505	12-2005	Schneider, Eric	709/245
*	ם	US-2002/0099605	07-2002	Weitzman et al.	705/14
	ш	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.